2025년 2월 12일(수)-14일(금) | 강원도 하이원리조트

Future Normal in Semiconductor

2025-02-14(금), 15:10-17:10

좌장: 추후업데이트 예정

K. Memory (Design & Process Technology) 분과

[FA3-K] Material, Process, Structures, Modeling for Advanced Memory Applications

초청 FA3-K-1 15:10-15:40	Flexible Synaptic Memristors for Wearable Neuro-Inspired Applications Sin-Hyung Lee Department of Intelligent Semiconductor Engineering, University of Seoul
FA3-K-2 15:40-15:55	Wafer Bonding Process와 수율 향상을 위한 계측 김해리, 최별, 안채영, 한경식, 김연수 SK hynix, R&D
FA3-K-3 15:55-16:10	Enhanced resistive switching stability in a memristor array utilizing highly polycrystalline two-dimensional material Jihoon Yang ¹ , Donghyun Lee ¹ , IL-John Jung ¹ , Dong-Hyeok Lim ¹ , Hongsik Jeong ¹ , Soon-Yong Kwon ¹ , Zonghoon Lee ^{1,2} , and Aram Yoon ^{1,2} ¹ Depatment of Materials Science and Engineering and Graduate School of Semiconductor Materials and Devices Engineering, UNIST, ² CMCM, IBS
FA3-K-4 16:10-16:25	Engineering Thermal Diffusion Control in Phase Change Heterostructures for High-Performance, High-Density Phase Change Memory Jun Young Choi ¹ , Tae Geun Kim ^{1,2} , Dong Hyun Kim ² , Jin Suk Oh ² , Jong Min Joo ² , Min Su Kang ² , and Ji Eun Park ² ¹ Department of Semiconductor System Engineering, Korea University, ² School of Electrical Engineering, Korea University
FA3-K-5 16:25-16:40	Limiting Active Electrode of Two-dimensional Memristor for Challenging Variance limit Sihoon Son ¹ , Hyunho Seok ¹ , Hyunbin Choi ² , Jinhyoung Lee ³ , and Taesung Kim ^{1,2,3} ¹ SKKU Advance Institute of Nano Technology, ² Department of Semiconductor Convergence Engineering, Sungkyunkwan University, ³ Department of Mechanical Engineering, Sungkyunkwan University



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FA3-K-6 16:40-16:55	Contact Area Size-Dependent Schottky Barrier Height of Memory
	Device
	Yoojin Seol, Hyeongyu Kim, Haecheol Hwang, Hyogyung Kim, and Kihyun Kim
	Department of Electronics and Information Engineering, Jeonbuk National University
	(JBNU)
	Fully_Coupled simulation of Bipolar Filamentary Resistive Switching by
FA3-K-7	Phase-field and Electrothermal Models
16:55-17:10	Jinwoo Oh, Dongmyung Jung, and Yongwoo Kwon
	Department of Materials Science and Engineering, Hongik University